Hiroyuki Fujiwara

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114 papers 4,985 citations

31 h-index

69 g-index

126 ext. papers

5,617 ext. citations

3.1 avg, IF

6.11 L-index

#	Paper	IF	Citations
114	2007,		1172
113	Effects of carrier concentration on the dielectric function of ZnO:Ga and In2O3:Sn studied by spectroscopic ellipsometry: Analysis of free-carrier and band-edge absorption. <i>Physical Review B</i> , 2005 , 71,	3.3	362
112	Optical Transitions in Hybrid Perovskite Solar Cells: Ellipsometry, Density Functional Theory, and Quantum Efficiency Analyses for CH3NH3PbI3. <i>Physical Review Applied</i> , 2016 , 5,	4.3	229
111	Assessment of effective-medium theories in the analysis of nucleation and microscopic surface roughness evolution for semiconductor thin films. <i>Physical Review B</i> , 2000 , 61, 10832-10844	3.3	213
110	Optimization of hydrogenated amorphous silicon plb solar cells with two-step i layers guided by real-time spectroscopic ellipsometry. <i>Applied Physics Letters</i> , 1998 , 73, 1526-1528	3.4	197
109	Hydrogen-doped In2O3as High-mobility Transparent Conductive Oxide. <i>Japanese Journal of Applied Physics</i> , 2007 , 46, L685-L687	1.4	180
108	Effects of a-Si:H layer thicknesses on the performance of a-Si:HĒ-Si heterojunction solar cells. <i>Journal of Applied Physics</i> , 2007 , 101, 054516	2.5	169
107	Impact of epitaxial growth at the heterointerface of a-Si:HĒ-Si solar cells. <i>Applied Physics Letters</i> , 2007 , 90, 013503	3.4	156
106	Degradation mechanism of CH3NH3PbI3 perovskite materials upon exposure to humid air. <i>Journal of Applied Physics</i> , 2016 , 119, 115501	2.5	140
105	Real-time spectroscopic ellipsometry studies of the nucleation and grain growth processes in microcrystalline silicon thin films. <i>Physical Review B</i> , 2001 , 63,	3.3	114
104	Enhancement of light trapping in thin-film hydrogenated microcrystalline Si solar cells using back reflectors with self-ordered dimple pattern. <i>Applied Physics Letters</i> , 2008 , 93, 143501	3.4	108
103	Hydrogen-doped In2O3 transparent conducting oxide films prepared by solid-phase crystallization method. <i>Journal of Applied Physics</i> , 2010 , 107, 033514	2.5	104
102	Application of hydrogenated amorphous silicon oxide layers to c-Si heterojunction solar cells. <i>Applied Physics Letters</i> , 2007 , 91, 133508	3.4	93
101	Dielectric function of Cu(In, Ga)Se2-based polycrystalline materials. <i>Journal of Applied Physics</i> , 2013 , 113, 063505	2.5	83
100	Quantitative determination of optical and recombination losses in thin-film photovoltaic devices based on external quantum efficiency analysis. <i>Journal of Applied Physics</i> , 2016 , 120, 064505	2.5	81
99	Dielectric function of a-Si:H based on local network structures. <i>Physical Review B</i> , 2011 , 83,	3.3	76
98	Real-time monitoring and process control in amorphous Trystalline silicon heterojunction solar cells by spectroscopic ellipsometry and infrared spectroscopy. <i>Applied Physics Letters</i> , 2005 , 86, 032112	3.4	75

(2012-2008)

97	Reduction of Optical Loss in Hydrogenated Amorphous Silicon/Crystalline Silicon Heterojunction Solar Cells by High-Mobility Hydrogen-Doped In2O3Transparent Conductive Oxide. <i>Applied Physics Express</i> , 2008 , 1, 041501	2.4	69	
96	Interface-layer formation mechanism in aBi:H thin-film growth studied by real-time spectroscopic ellipsometry and infrared spectroscopy. <i>Physical Review B</i> , 1999 , 60, 13598-13604	3.3	67	
95	Universal rules for visible-light absorption in hybrid perovskite materials. <i>Journal of Applied Physics</i> , 2017 , 121, 115501	2.5	61	
94	Back surface reflectors with periodic textures fabricated by self-ordering process for light trapping in thin-film microcrystalline silicon solar cells. <i>Solar Energy Materials and Solar Cells</i> , 2009 , 93, 1087-109	o ^{6.4}	60	
93	Depth profiling of siliconflydrogen bonding modes in amorphous and microcrystalline Si:H thin films by real-time infrared spectroscopy and spectroscopic ellipsometry. <i>Journal of Applied Physics</i> , 2002 , 91, 4181-4190	2.5	51	
92	Quantitative Assessment of Optical Gain and Loss in Submicron-Textured CuIn1\(\text{IGaxSe2 Solar Cells Fabricated by Three-Stage Coevaporation. } Physical Review Applied, 2014 , 2,	4.3	50	
91	Stress-Induced Nucleation of Microcrystalline Silicon from Amorphous Phase. <i>Japanese Journal of Applied Physics</i> , 2002 , 41, 2821-2828	1.4	50	
90	Interface-layer formation in microcrystalline Si:H growth on ZnO substrates studied by real-time spectroscopic ellipsometry and infrared spectroscopy. <i>Journal of Applied Physics</i> , 2003 , 93, 2400-2409	2.5	45	
89	Microcrystalline silicon nucleation sites in the sub-surface of hydrogenated amorphous silicon. <i>Surface Science</i> , 2002 , 497, 333-340	1.8	45	
88	Optoelectronic properties of Mg2Si semiconducting layers with high absorption coefficients. <i>Journal of Applied Physics</i> , 2011 , 110, 063723	2.5	44	
87	Optical constants of Cu(In, Ga)Se2 for arbitrary Cu and Ga compositions. <i>Journal of Applied Physics</i> , 2015 , 117, 195703	2.5	39	
86	Dielectric functions of Cu2ZnSnSe4 and Cu2SnSe3 semiconductors. <i>Journal of Applied Physics</i> , 2015 , 117, 015702	2.5	38	
85	Structural and electrical properties of hydrogen-doped . <i>Journal of Non-Crystalline Solids</i> , 2008 , 354, 28	05.380	0837	
84	Real time spectroscopic ellipsometry studies of the nucleation and growth of p-type microcrystalline silicon films on amorphous silicon using B2H6, B(CH3)3 and BF3 dopant source gases. <i>Journal of Applied Physics</i> , 1999 , 85, 4141-4153	2.5	34	
83	Extraordinary Strong Band-Edge Absorption in Distorted Chalcogenide Perovskites. <i>Solar Rrl</i> , 2020 , 4, 1900555	7.1	31	
82	Optical Characteristics and Operational Principles of Hybrid Perovskite Solar Cells. <i>Physica Status Solidi (A) Applications and Materials Science</i> , 2018 , 215, 1700730	1.6	31	
81	Tail state formation in solar cell materials: First principles analyses of zincblende, chalcopyrite, kesterite, and hybrid perovskite crystals. <i>Physical Review Materials</i> , 2018 , 2,	3.2	30	
80	Correlation between oxygen stoichiometry, structure, and opto-electrical properties in amorphous In2O3:H films. <i>Journal of Applied Physics</i> , 2012 , 111, 063721	2.5	29	

79	Fundamental aspects of low-temperature growth of microcrystalline silicon. <i>Thin Solid Films</i> , 2003 , 430, 130-134	2.2	29
78	Microcrystalline Si1-xGexSolar Cells Exhibiting Enhanced Infrared Response with Reduced Absorber Thickness. <i>Applied Physics Express</i> , 2008 , 1, 031501	2.4	27
77	High-precision characterization of textured a-Si:H/SnO2:F structures by spectroscopic ellipsometry. Journal of Applied Physics, 2011 , 110, 073518	2.5	25
76	Optical depth profiling of band gap engineered interfaces in amorphous silicon solar cells at monolayer resolution. <i>Applied Physics Letters</i> , 1998 , 72, 2993-2995	3.4	22
75	Top-down prepared silicon nanocrystals and a conjugated polymer-based bulk heterojunction: Optoelectronic and photovoltaic applications. <i>Acta Materialia</i> , 2009 , 57, 5986-5995	8.4	21
74	Complete parameterization of the dielectric function of microcrystalline silicon fabricated by plasma-enhanced chemical vapor deposition. <i>Journal of Applied Physics</i> , 2012 , 111, 083509	2.5	21
73	Nucleation mechanism of microcrystalline silicon from the amorphous phase. <i>Journal of Non-Crystalline Solids</i> , 2004 , 338-340, 97-101	3.9	20
72	Optimization of interface structures in crystalline silicon heterojunction solar cells. <i>Solar Energy Materials and Solar Cells</i> , 2009 , 93, 725-728	6.4	19
71	Highly accurate prediction of material optical properties based on density functional theory. <i>Computational Materials Science</i> , 2020 , 172, 109315	3.2	19
70	Very small tail state formation in Cu2ZnGeSe4. <i>Applied Physics Letters</i> , 2018 , 113, 093901	3.4	19
69	Perovskite Color Detectors: Approaching the Efficiency Limit. <i>ACS Applied Materials & Amp; Interfaces</i> , 2020 , 12, 47831-47839	9.5	18
68	Determination and interpretation of the optical constants for solar cell materials. <i>Applied Surface Science</i> , 2017 , 421, 276-282	6.7	17
67	Application of real time spectroscopic ellipsometry for high resolution depth profiling of compositionally graded amorphous silicon alloy thin films. <i>Applied Physics Letters</i> , 1997 , 70, 2150-2152	3.4	17
66	Ellipsometry characterization of polycrystalline ZnO layers with the modeling of carrier concentration gradient: Effects of grain boundary, humidity, and surface texture. <i>Journal of Applied Physics</i> , 2014 , 115, 133505	2.5	16
65	Vertically Stacked Perovskite Detectors for Color Sensing and Color Vision. <i>Advanced Materials Interfaces</i> , 2020 , 7, 2000459	4.6	15
64	Optical emission spectroscopy of atmospheric pressure microwave plasmas. <i>Journal of Applied Physics</i> , 2008 , 104, 054908	2.5	14
63	Improved transport and photostability of poly(methoxy-ethylexyloxy-phenylenevinilene) polymer thin films by boron doped freestanding silicon nanocrystals. <i>Applied Physics Letters</i> , 2008 , 92, 143301	3.4	14
62	Ellipsometry characterization of a-Si:H layers for thin-film solar cells. <i>Journal of Non-Crystalline Solids</i> , 2012 , 358, 2257-2259	3.9	13

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Crystalline Si Heterojunction Solar Cells with the Double Heterostructure of Hydrogenated Amorphous Silicon Oxide. <i>Japanese Journal of Applied Physics</i> , 2009 , 48, 064506	1.4	13
Principles of Spectroscopic Ellipsometry81-146		13
Real-time characterization of free-carrier absorption during epitaxial Si p-layer growth. <i>Applied Physics Letters</i> , 2003 , 82, 1227-1229	3.4	12
Real time spectroscopic ellipsometry characterization of structural and thermal equilibration of amorphous silicontarbon alloy p layers in p-i-n solar cell fabrication. <i>Journal of Applied Physics</i> , 1998, 84, 2278-2286	2.5	12
Maximum Efficiencies and Performance-Limiting Factors of Inorganic and Hybrid Perovskite Solar Cells. <i>Physical Review Applied</i> , 2019 , 12,	4.3	11
Network structure of a-SiO:H layers fabricated by plasma-enhanced chemical vapor deposition: Comparison with a-SiC:H layers. <i>Journal of Non-Crystalline Solids</i> , 2016 , 440, 49-58	3.9	11
Characterization of E-Si:H/a-Si:H tandem solar cell structures by spectroscopic ellipsometry. <i>Thin Solid Films</i> , 2014 , 571, 756-761	2.2	11
Optical characterization of textured SnO2:F layers using spectroscopic ellipsometry. <i>Journal of Applied Physics</i> , 2012 , 112, 083507	2.5	11
Ellipsometry Characterization of Hydrogenated Amorphous Silicon Layers Formed on Textured Crystalline Silicon Substrates. <i>Applied Physics Express</i> , 2010 , 3, 116604	2.4	11
Characterization of textured SnO2:F layers by ellipsometry using glass-side illumination. <i>Thin Solid Films</i> , 2013 , 534, 149-154	2.2	10
Breaking network connectivity leads to ultralow thermal conductivities in fully dense amorphous solids. <i>Applied Physics Letters</i> , 2016 , 109, 191905	3.4	10
Optimization of amorphous semiconductors and low-/high-k dielectrics through percolation and topological constraint theory. <i>MRS Bulletin</i> , 2017 , 42, 39-44	3.2	9
Nondestructive characterization of textured a-Si:H/c-Si heterojunction solar cell structures with nanometer-scale a-Si:H and In2O3:Sn layers by spectroscopic ellipsometry. <i>Journal of Applied Physics</i> , 2013 , 114, 043101	2.5	9
Luminescent properties of doped freestanding silicon nanocrystals embedded in MEH-PPV. <i>Solar Energy Materials and Solar Cells</i> , 2009 , 93, 774-778	6.4	9
Fast determination of the current loss mechanisms in textured crystalline Si-based solar cells. <i>Journal of Applied Physics</i> , 2017 , 122, 203101	2.5	8
Real-time studies of amorphous and microcrystalline Si:H growth by spectroscopic ellipsometry and infrared spectroscopy. <i>Thin Solid Films</i> , 2004 , 455-456, 670-674	2.2	8
Analysis of contamination, hydrogen emission, and surface temperature variations using real time spectroscopic ellipsometry during p/i interface formation in amorphous silicon p-i-n solar cells. <i>Applied Physics Letters</i> , 1999 , 74, 3687-3689	3.4	8
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43	Local network structure of a-SiC:H and its correlation with dielectric function. <i>Journal of Applied Physics</i> , 2013 , 114, 233513	2.5	7
42	Understanding of Passivation Mechanism in Heterojunction c-Si Solar Cells. <i>Materials Research Society Symposia Proceedings</i> , 2008 , 1066, 1		7
41	Ellipsometry analysis of a-Si:H solar cell structures with submicron-size textures using glass-side illumination. <i>Thin Solid Films</i> , 2014 , 565, 222-227	2.2	6
40	Growth of hydrogenated amorphous silicon and its alloys. <i>Current Opinion in Solid State and Materials Science</i> , 1997 , 2, 417-424	12	6
39	Impact of annealing on passivation of a-Si:H / c-Si heterostructures. <i>Conference Record of the IEEE Photovoltaic Specialists Conference</i> , 2008 ,		6
38	Mapping Characterization of SnO2:F Transparent Conductive Oxide Layers by Ellipsometry Technique. <i>Japanese Journal of Applied Physics</i> , 2012 , 51, 10NB01	1.4	6
37	Mapping Characterization of SnO\$_{2}\$:F Transparent Conductive Oxide Layers by Ellipsometry Technique. <i>Japanese Journal of Applied Physics</i> , 2012 , 51, 10NB01	1.4	5
36	Effect of Strained Si-Si Bonds in Amorphous Silicon Incubation Layer on Microcrystalline Silicon Nucleation. <i>Materials Research Society Symposia Proceedings</i> , 2001 , 664, 121		5
35	Interface Structure in a-Si:H/c-Si Heterojunction Solar Cells Characterized by Optical Diagnosis Technique 2006 ,		4
34	Light-Induced Conductivity Enhancement in Boron-Doped Zinc Oxide Thin Films Deposited by Low-Pressure Chemical Vapor Deposition. <i>Applied Physics Express</i> , 2012 , 5, 085802	2.4	3
33	Real-time observation of the energy band diagram during microcrystalline silicon plinterface formation. <i>Applied Physics Letters</i> , 2003 , 83, 4348-4350	3.4	3
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31	Application of Spectroscopic Ellipsometry and Infrared Spectroscopy for the Real-Time Control and Characterization of a-Si:H Growth in a-Si:H/c-Si Heterojunction Solar Cells. <i>Materials Research Society Symposia Proceedings</i> , 2005 , 862, 1411		2
30	Ellipsometry 2009 ,		2
29	Effect of Roughness on Ellipsometry Analysis. Springer Series in Optical Sciences, 2018, 155-172	0.5	2
28	Analysis of Optical and Recombination Losses in Solar Cells. Springer Series in Optical Sciences, 2018, 29-	82 5	2
27	Ultrafast deposition of microcrystalline silicon films using high-density microwave plasma. <i>Solar Energy Materials and Solar Cells</i> , 2009 , 93, 812-815	6.4	1
26	Evolution of Film Crystalline Structure During the Ultrafast Deposition of Crystalline Si Films. <i>Materials Research Society Symposia Proceedings</i> , 2008 , 1066, 1		1

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25	Very high oscillator strength in the band-edge light absorption of zincblende, chalcopyrite, kesterite, and hybrid perovskite solar cell materials. <i>Physical Review Materials</i> , 2020 , 4,	3.2	1
24	Operational Principles of Hybrid Perovskite Solar Cells 2021 , 275-308		1
23	Organic-Inorganic Hybrid Perovskite Solar Cells. Springer Series in Optical Sciences, 2018, 463-507	0.5	1
22	Transparent Conductive Oxide Materials. Springer Series in Optical Sciences, 2018, 523-563	0.5	1
21	Organic-Inorganic Hybrid Perovskites. Springer Series in Optical Sciences, 2018, 471-493	0.5	1
20	Substrates and Coating Layers. Springer Series in Optical Sciences, 2018, 575-608	0.5	1
19	Inorganic Semiconductors and Passivation Layers. Springer Series in Optical Sciences, 2018, 319-426	0.5	1
18	Band-Gap-Engineered Transparent Perovskite Solar Modules to Combine Photovoltaics with Photosynthesis. <i>ACS Applied Materials & Samp; Interfaces</i> , 2021 , 13, 39230-39238	9.5	1
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16	Fully automated spectroscopic ellipsometry analyses: Application to MoOx thin films. <i>Journal of Applied Physics</i> , 2021 , 129, 243102	2.5	O
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6	Development and Stagnation of Ellipsometry Research Field in Japan. <i>Hyomen Kagaku</i> , 2014 , 35, 285-2	85
5	Optical Properties of Cu(In,Ga)Se2. Springer Series in Optical Sciences, 2018, 253-280	0.5
4	Amorphous/Crystalline Si Heterojunction Solar Cells. Springer Series in Optical Sciences, 2018, 227-252	0.5
3	Transparent Conductive Oxides. Springer Series in Optical Sciences, 2018, 495-541	0.5
2	Characterization of Textured Structures. Springer Series in Optical Sciences, 2018, 139-168	0.5
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